

<b>Notice of References Cited</b>	Application/Control No. 10/774,423		Applicant(s)/Patent Under Reexamination NAGASHIMA ET AL.	
	Examiner YEWEBDAR T. TADESSE		Art Unit 1792	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0200918	10-2003	NAGASHIMA et al.	118/58
*	B	US-6,398,430	06-2002	Jeoung et al.	396/611
*	C	US-2002/0195437	12-2002	Kusuda, Tatsufumi	219/390
*	D	US-4,983,546	01-1991	Hyun et al.	438/800
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
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	S					
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**NON-PATENT DOCUMENTS**

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